

OptiMOS[®]3 Power-Transistor

Features

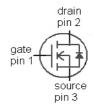
- N-channel, normal level
- Excellent gate charge x R DS(on) product (FOM)
- Very low on-resistance R DS(on)
- 175 °C operating temperature
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC¹⁾ for target application
- Ideal for high-frequency switching and synchronous rectification

Туре	IPP028N08N3 G	IPI028N08N3 G
	123	123
Package	PG-TO220-3	PG-TO262-3
Marking	028N08N	028N08N

Product Summary

V _{DS}	80	٧
R _{DS(on),max}	2.8	mΩ
I _D	100	Α

previous engineering sample codes: IPP02CN08N



Maximum ratings, at T_j =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I _D	T _C =25 °C ²⁾	100	А
		T _C =100 °C	100	
Pulsed drain current ²⁾	I _{D,pulse}	T _C =25 °C	400	
Avalanche energy, single pulse	E _{AS}	$I_{\rm D}$ =100 A, $R_{\rm GS}$ =25 Ω	1430	mJ
Gate source voltage	V_{GS}		±20	V
Power dissipation	P_{tot}	T _C =25 °C	300	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$		-55 175	°C
IEC climatic category; DIN IEC 68-1			55/175/56	



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Parameter	Symbol	Conditions	Values		Unit		
			min.	typ.	max.		
Thermal characteristics							
Thermal resistance, junction - case	R _{thJC}		-	-	0.5	K/W	
Thermal resistance,	R_{thJA}	minimal footprint	-	-	62		
junction - ambient		6 cm ² cooling area ³⁾	-	-	40		

Electrical characteristics, at T_j =25 °C, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} =0 V, I _D =1 mA	80	-	-	V
Gate threshold voltage	$V_{\rm GS(th)}$	V _{DS} =V _{GS} , I _D =270 μA	2	2.8	3.5	
Zero gate voltage drain current	I _{DSS}	V _{DS} =80 V, V _{GS} =0 V, T _j =25 °C	1	0.1	1	μΑ
		V _{DS} =80 V, V _{GS} =0 V, T _j =125 °C	-	10	100	
Gate-source leakage current	I _{GSS}	V _{GS} =20 V, V _{DS} =0 V	-	1	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	V _{GS} =10 V, I _D =100 A	-	2.4	2.8	mΩ
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =10 V, I _D =100 A V _{GS} =6 V, I _D =50 A	-	2.4	2.8 4.2	mΩ
Drain-source on-state resistance Gate resistance	R _{DS(on)}					mΩ

¹⁾J-STD20 and JESD22

²⁾ See figure 3

 $^{^{3)}}$ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm 2 (one layer, 70 μ m thick) copper area for drain connection. PCB is vertical in still air.



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Parameter	Symbol Conditions		Values			Unit
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	C iss		-	10700	14200	pF
Output capacitance	C _{oss}	V _{GS} =0 V, V _{DS} =40 V, f=1 MHz	-	2890	3840	1
Reverse transfer capacitance	C _{rss}]	-	100	150	1
Turn-on delay time	t _{d(on)}		-	28	-	ns
Rise time	t _r	V _{DD} =40 V, V _{GS} =10 V,	-	73	-	
Turn-off delay time	$t_{d(off)}$	$I_{\rm D}$ =100 A, $R_{\rm G}$ =1.6 Ω	-	86	-	
Fall time	t _f		-	33	-	
Gate Charge Characteristics ⁴⁾						
Gate to source charge	Q _{gs}		-	50	67	nC
Gate to drain charge	Q_{gd}].,, ,	-	30	45	
Switching charge	Q_{sw}	V _{DD} =40 V, / _D =100 A, V _{GS} =0 to 10 V	-	50	72	
Gate charge total	Q _g		-	155	206	
Gate plateau voltage	V _{plateau}		ı	4.7	ı	٧
Output charge	Q oss	V _{DD} =40 V, V _{GS} =0 V	-	210	279	nC
Reverse Diode						
Diode continous forward current	Is	T -25 °C	-	-	100	А
Diode pulse current	/ _{S,pulse}	T _C =25 °C	-	-	400	
Diode forward voltage	V _{SD}	V _{GS} =0 V, I _F =100 A, T _j =25 °C	-	1.0	1.2	V
Reverse recovery time	t rr	V _R =40 V, I _F =I _S ,	-	113	-	ns
Reverse recovery charge	Q _{rr}	d <i>i</i> _F /d <i>t</i> =100 A/μs	-	317	-	nC

⁴⁾ See figure 16 for gate charge parameter definition



1 Power dissipation

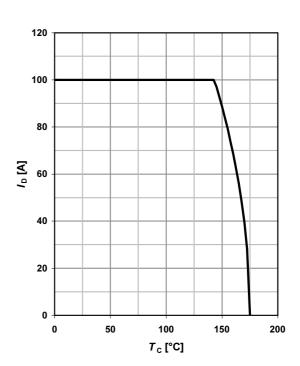
P_{tot} =f(T_{C})

350 300 250 200 150 100 50 0 0 0 50 100 150 200

 $T_{\rm C}$ [°C]

2 Drain current

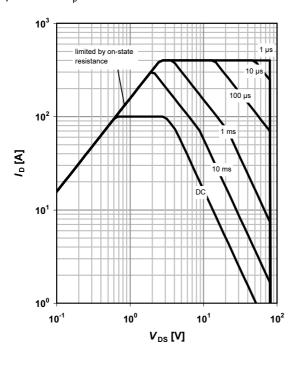
$$I_D = f(T_C); V_{GS} \ge 10 \text{ V}$$



3 Safe operating area

$$I_D$$
=f(V_{DS}); T_C =25 °C; D =0

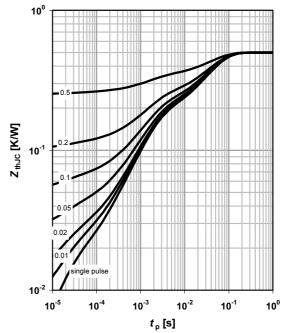
parameter: t_p



4 Max. transient thermal impedance

$$Z_{thJC}$$
=f(t_p)

parameter: $D = t_p/T$

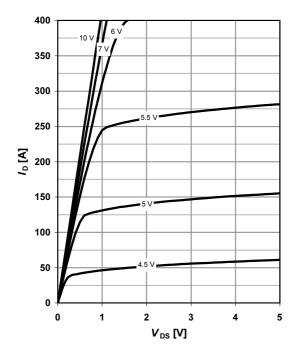




5 Typ. output characteristics

 $I_D=f(V_{DS}); T_j=25 \text{ °C}$

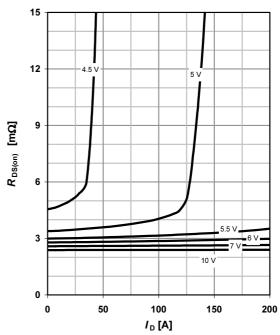
parameter: V_{GS}



6 Typ. drain-source on resistance

 $R_{DS(on)}$ =f(I_D); T_j =25 °C

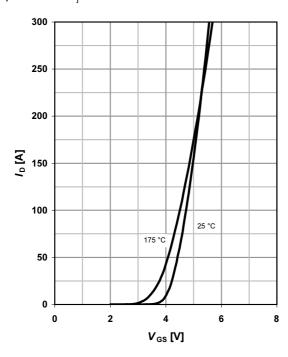
parameter: $V_{\rm GS}$



7 Typ. transfer characteristics

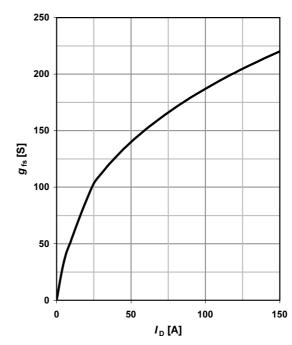
 $I_{\rm D}$ =f($V_{\rm GS}$); $|V_{\rm DS}|$ >2 $|I_{\rm D}|R_{\rm DS(on)max}$

parameter: T_j



8 Typ. forward transconductance

 g_{fs} =f(I_D); T_j =25 °C





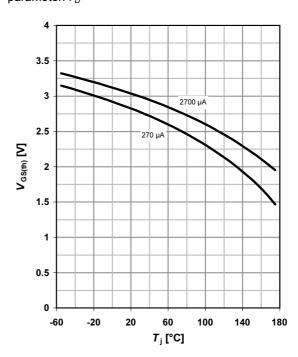
9 Drain-source on-state resistance

 $R_{DS(on)}$ =f(T_j); I_D =100 A; V_{GS} =10 V

*T*_j [°C]

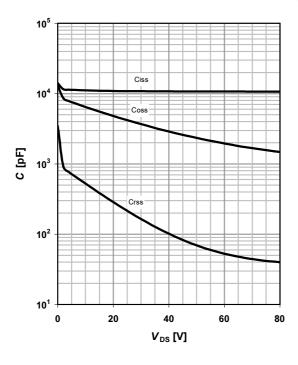
10 Typ. gate threshold voltage

 $V_{\rm GS(th)}$ =f($T_{\rm j}$); $V_{\rm GS}$ = $V_{\rm DS}$ parameter: $I_{\rm D}$



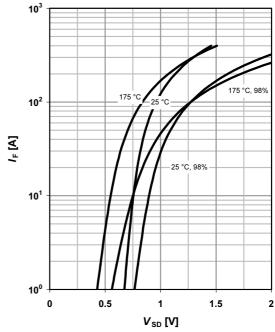
11 Typ. capacitances

 $C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$



12 Forward characteristics of reverse diode

 I_{F} =f(V_{SD})
parameter: T_{j}





13 Avalanche characteristics

 I_{AS} =f(t_{AV}); R_{GS} =25 Ω

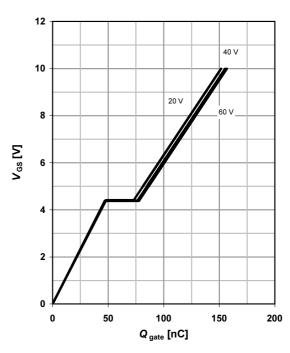
parameter: $T_{\rm j(start)}$

1000 100 25°C 150°C 100°C 100°C

14 Typ. gate charge

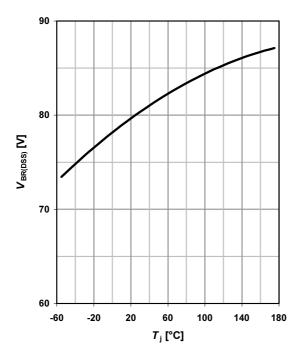
 $V_{\rm GS}$ =f(Q_{gate}); $I_{\rm D}$ =50 A pulsed

parameter: $V_{\rm DD}$

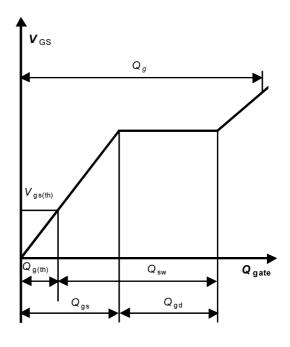


15 Drain-source breakdown voltage

 $V_{BR(DSS)}$ =f(T_j); I_D =1 mA

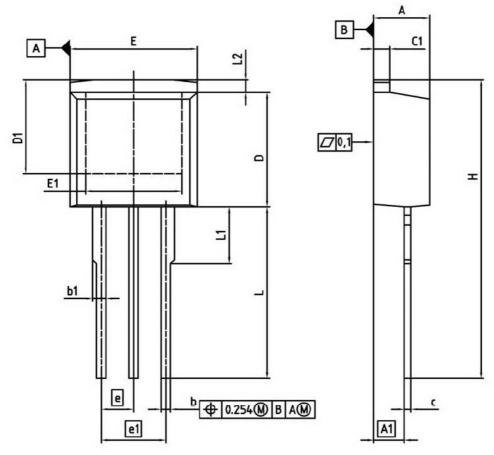


16 Gate charge waveforms

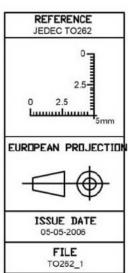




PG-TO262-3 (I²-Pak)

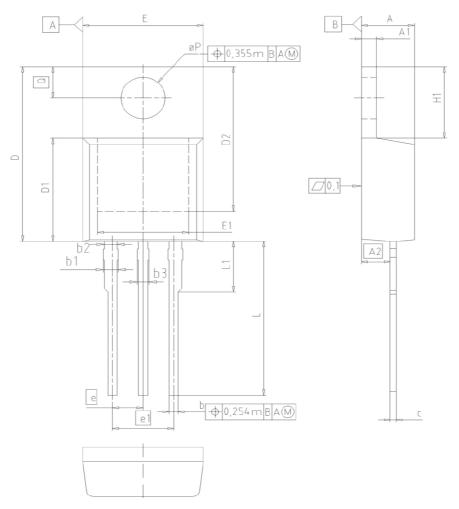


DIM	MILLIM	ETERS	INC	HES
	MIN	MAX	MIN	MAX
Α	4.300	4.572	0.169	0.180
A1	2.150	2.718	0.085	0.107
b	0.650	0.864	0.026	0.034
b1	0.635	1.400	0.025	0.055
С	0.330	0.600	0.013	0.024
c1	1.170	1.400	0.046	0.055
D	8.509	9.450	0.335	0.372
D1	6.900		0.272	-
E	9.700	10.363	0.382	0.408
E1	6.500	8.600	0.256	0.339
e	2.5	40	0.100	
el	5.0	80	0.2	200
N	3	3		3
L	13.000	14.000	0.512	0.551
L1		4.800		0.189
L2		1.727		0.068

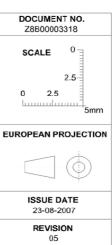




PG-TO220-3



DIM	MILLIN	METERS	INCHES		
DIN	MIN	MAX	MIN	MAX	
Α	4.30	4.57	0.169	0.180	
A1	1.17	1.40	0.046	0.055	
A2	2.15	2.72	0.085	0.107	
b	0.65	0.86	0.026	0.034	
b1	0.95	1.40	0.037	0.055	
b2	0.95	1.15	0.037	0.045	
b3	0.65	1.15	0.026	0.045	
С	0.33	0.60	0.013	0.024	
D	14.81	15.95	0.583	0.628	
D1	8.51	9.45	0.335	0.372	
D2	12.19	13.10	0.480	0.516	
E	9.70	10.36	0.382	0.408	
E1	6.50	8.60	0.256	0.339	
е	2.	54	0.100		
e1	5.08		0.200		
N		3		3	
H1	5.90	6.90	0.232	0.272	
L	13.00	14.00	0.512	0.551	
L1	-	4.80	-	0.189	
øP	3.60	3.89	0.142	0.153	
Q	2.60	3.00	0.102	0.118	





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